



RSS-102.NS.SIM  
Issue 1  
June 5, 2023  
Draft

Spectrum Management and Telecommunications

Radio Standards Specification

# **Simulation procedure for assessing nerve stimulation (NS) compliance in accordance with RSS-102**

## Preface

This Innovation, Science and Economic Development Canada (ISED) radio standard describes the technical requirements and assessment procedures for demonstrating compliance of radio apparatus with the radiofrequency (RF) exposure limits outlined in RSS-102 from 3 kHz to 10 MHz. It applies to all radio apparatus producing RF emissions in this range. It also applies to some interference-causing equipment, specifically Industrial, Scientific and Medical (ISM) equipment.

Radio Standards Specification RSS-102.NS, issue 1, *Assessing NS compliance in accordance with RSS-102*, replaces the following document:

- i. SPR-002, issue 2, Supplementary Procedure for Assessing Compliance of Equipment Operating from 3 kHz to 10 MHz with RSS-102, dated October 2022

This document is associated with the modernization of RSS-102. All NS-related procedures using simulations are consolidated into this document to simplify the identification of procedures related to NS testing.

The content is nearly identical to SPR-002 issue 2, except for:

1. requirements for SN measurements are now located in RSS-102.NS.MEAS;
2. requirements for SAR-related measurements are now located in RSS-102.SAR.MEAS;
3. requirements for SAR-related simulations will be located in RSS-102.SAR.SIM;
4. requirements for calculation of the uncertainty were clarified; and
5. various editorial changes.

Issued under the authority of the Minister of Industry

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Martin Proulx  
Director General  
Engineering, Planning and Standards Branch

- 41 Inquiries may be submitted by one of the following methods:
- 42 1. Online using the [General Inquiry](#) form (in the form, select the Directorate of  
43 Regulatory Standards radio button and specify “RSS-102” in the General Inquiry  
44 field)
- 45 2. By mail to the following address:
- 46
- 47 Innovation, Science and Economic Development Canada  
48 Engineering, Planning and Standards Branch  
49 Attention: Regulatory Standards Directorate  
50 235 Queen Street  
51 Ottawa ON K1A 0H5  
52 Canada
- 53 3. By email to [consultationradiostandards-consultationnormesradio@ised-isde.gc.ca](mailto:consultationradiostandards-consultationnormesradio@ised-isde.gc.ca)
- 54

55 Comments and suggestions for improving this standard may be submitted online using  
56 the [Standard Change Request](#) form or by mail or email to the above addresses.  
57 All spectrum and telecommunications related documents are available on ISED’s [Spectrum](#)  
58 [Management and Telecommunications](#) website.

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94 **1. Scope**

95  
96 RSS-102.NS.SIM, issue 1, sets out the computational electromagnetics simulation  
97 methods for assessing compliance of equipment operating in the frequency range from 3  
98 kHz to 10 MHz with the RF exposure limits to prevent nerve stimulation (NS) as outlined in  
99 RSS-102.

100  
101 The requirements within this document also apply to wireless power transfer (WPT) source  
102 subassemblies, including Type 1, which are classified as interference-causing equipment.  
103

104 **1.1. Purpose and application**

105  
106 RSS-102.NS.SIM provides general requirements for computational electromagnetics-based  
107 assessments of RF exposure in the range of 3 kHz to 10 MHz.

108  
109 The annexes of RSS-102.NS.SIM are normative. References to annexes in RSS-  
110 102.NS.MEAS within this document are normative to this standard.

111  
112 ISED may consider assessment methods not covered by RSS-102.NS.SIM or the  
113 normative references listed in section 2. For more information regarding the acceptability of  
114 alternative assessment methods, consult the following [website](#). Alternatively, detailed  
115 inquiries relating to measurement methods may be submitted to [certificationbureau-  
bureauhomologation@ised-isde.gc.ca](mailto:certificationbureau-<br/>116 bureauhomologation@ised-isde.gc.ca), while those relating to computational methods may  
117 be submitted to [consultationradiostandards-consultationnormesradio@ised-isde.gc.ca](mailto:consultationradiostandards-consultationnormesradio@ised-isde.gc.ca).

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120 **1.2. Transition period**  
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122 This document will be in force upon publication on Innovation, Science and Economic  
123 Development Canada's (ISED) website. RSS-102.NS.SIM is neither adding nor resetting  
124 the transition period for SPR-002 issue 2 that was initiated in October 2022; consequently,  
125 the transition period ends on **October 4, 2023**. Before this date, certification using the  
126 requirements of SPR-002, issue 1 or issue 2 will be accepted. After this period, only  
127 applications for certification of equipment using RSS-102.NS.MEAS or RSS-102.NS.SIM  
128 issue 1, will be accepted and equipment manufactured, imported, distributed, leased,  
129 offered for sale, or sold in Canada, shall comply with this issue.

130  
131 A copy of SPR-002, issue 2, may be requested by email at [consultationradiostandards-  
132 consultationnormesradio@ised-isde.gc.ca](mailto:consultationradiostandards-consultationnormesradio@ised-isde.gc.ca).

133  
134 **2. Normative references**  
135

136 The following documents shall be consulted for the application of RSS-102.NS.SIM. Unless  
137 an edition is specified, the most recent versions of these publications shall be considered.  
138

- 139 • [\*Safety Code 6 — Health Canada's Radiofrequency Exposure Guidelines\*](#)
- 140
- 141 • [\*Technical Guide for Interpretation and Compliance Assessment of Health Canada's  
142 Radiofrequency Exposure Guidelines\*](#)
- 143
- 144 • Radio Standards Specification RSS-102, [\*Radio Frequency \(RF\) Exposure  
145 Compliance of Radiocommunication Apparatus \(All Frequency Bands\)\*](#)
- 146
- 147 • IEC/IEEE 62704-1, [\*Determining the peak spatial-average specific absorption rate  
148 \(SAR\) in the human body from wireless communications devices, 30 MHz to 6 GHz  
149 - Part 1: General requirements for using the finite-difference time-domain \(FDTD\)  
150 method for SAR calculations\*](#)
- 151
- 152 • IEC/IEEE 62704-4, [\*Determining the peak spatial-average specific absorption rate  
153 \(SAR\) in the human body from wireless communications devices, 30 MHz to 6 GHz  
154 - Part 4: General requirements for using the finite element method for SAR  
155 calculations\*](#)
- 156

157 **3. Definitions, abbreviations and symbols/units**  
158

159 This section provides definitions and abbreviations/acronyms for terms used in this  
160 document, as well as the symbols/units used for quantities.  
161

162 **3.1. Definitions**  
163

164 In addition to the definitions in RSS-102, the following definitions are applicable to this  
165 standard.  
166

167 **Evaluation surface:** The surface upon which incident fields are evaluated in assessments  
168 against the reference levels.  
169

170 **Exposure region:** The region in space over which an RF exposure assessment is  
171 performed. For assessments against the basic restrictions, the exposure region  
172 corresponds to the volume of space that would be occupied by a tissue-equivalent  
173 phantom, whereas for assessments against the reference levels, it corresponds to the  
174 evaluation surface.  
175

176 **Far-field (region):** The space around an antenna or other radiating structure where the  
177 angular field distribution begins to be essentially independent of the distance from the  
178 antenna. In this space, the field has a predominantly plane-wave character. Please refer to  
179 [TN-261](#) for further details regarding antenna field regions.  
180

181 **Instantaneous root-mean-square (RMS) value:** The square root of the average of the  
182 square of the instantaneous waveform amplitude taken throughout one period of the  
183 highest frequency component associated with the waveforms generated by a transmitter of  
184 the EUT.  
185

186 **Maximum instantaneous root-mean-square (RMS) value:** The temporal maximum  
187 instantaneous RMS value.  
188

189 **Near-field (region):** The volume of space surrounding an antenna or other radiating  
190 structure in which the electric and magnetic fields do not have a substantially plane-wave  
191 character, but vary considerably from point to point at the same distance from the source.  
192 Please refer to [TN-261](#) for further details regarding antenna field regions.  
193

194 **Power transfer management:** Capability of some WPT devices to exchange information  
195 related to the power transfer operation between the source and client devices for purposes  
196 such as detecting invalid client devices or objects, communicating status information,  
197 sending commands from the source to the client and sending acknowledgements from the  
198 client to the source.  
199

200 **Reactive near-field (region):** Sub-region within the near-field region of an antenna or other  
201 radiating structure where evanescent fields are dominant. The reactive near-field region  
202 extends to a distance of at least  $\lambda/2\pi$  from the antenna, where  $\lambda$  is the wavelength in  
203 meters. Please refer to [TN-261](#) for further details regarding antenna field regions.

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**Wireless power transfer (WPT):** The transfer of energy from one or more source devices to one or more client devices through electromagnetic waves or fields using magnetic field (inductive or resonant), electric field (capacitive or resonant), or radiative means, with no electrical contact between the source device(s) and client device(s), for the purpose of powering and/or charging the client device(s) wirelessly.

**WPT client:** A device capable of receiving power wirelessly from a WPT source.

**WPT source:** A device directly connected (i.e. through a wired connection) to a power source, e.g. AC mains, a battery or some other source of internal or external electrical power, which is capable of wireless power transfer to one or more WPT clients.

### 3.2. Abbreviations and acronyms

This document uses the following abbreviations and acronyms:

<b>EUT</b>	Equipment under test
<b>EV</b>	Electric vehicle
<b>FDTD</b>	Finite-difference time-domain
<b>FEM</b>	Finite element method
<b>FFT</b>	Fast Fourier transform
<b>FIT</b>	Finite integration technique
<b>ISED</b>	Innovation, Science and Economic Development Canada
<b>NS</b>	Nerve stimulation
<b>OBW</b>	Occupied bandwidth
<b>RBW</b>	Resolution bandwidth
<b>RF</b>	Radio frequency
<b>RMS</b>	Root mean square
<b>SAR</b>	Specific absorption rate
<b>WPT</b>	Wireless power transfer

### 3.3. Quantities

Table 3-1 lists the quantities used throughout this document along with their internationally accepted SI units.

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**Table 3-1 – Quantities and constant**

Quantity	Symbol	Unit
Magnetic Flux Density	$B$	tesla (T)
Electric Field Strength	$E$	volt per meter (V/m)
Frequency	$f$	hertz (Hz)
Magnetic Field Strength	$H$	ampere per meter (A/m)
Specific Absorption Rate	$SAR$	watt per kilogram (W/kg)
Wavelength	$\lambda$	metre (m)
Permeability (free space)	$\mu_0$	$4 \cdot \pi \times 10^{-7}$ (H/m)

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**4. General requirements**

The general requirements summarized in section 4 of RSS-102.NS.MEAS apply for simulation-based analyses. The following requirements are in addition to those outlined in section 4 of RSS-102.NS.MEAS.

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**4.1. Operational description – Antennas**

The following operational description of each antenna shall be provided in the RF exposure technical brief in addition to those outlined in section 4.3.2 in RSS-102.NS.MEAS:

- the input impedance, inductance or capacitance of each element, as applicable;
- the method(s) of shielding or field shaping; and
- all relevant material properties, including those of the enclosure(s).

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**5. Computational assessments**

This section provides the requirements that are specific to computational assessments, whether they be performed against the basic restrictions or reference levels.

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**5.1. Computational tool and method**

The computational tool shall be clearly identified in the RF exposure technical brief. Ideally, it should employ one of the following full-wave computational methods:

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 276

- finite difference time domain (FDTD) / finite integration technique (FIT)
- finite element method (FEM)

277 Computational methods employing quasi-static approximations of Maxwell equations are  
278 acceptable for electrically small applications in the frequency range of this document.  
279

280 Otherwise, an [inquiry](#) shall be submitted to ISED, which describes the proposed method  
281 and how it can be used to perform a conservative RF exposure assessment.  
282

## 283 **5.2. Code verification**

284

285 The selected tool shall be demonstrated to meet the code verification requirements outlined  
286 in the international standard that most closely aligns with the chosen technique, e.g.  
287 IEC/IEEE 62704-1 for FDTD/FIT or IEC/IEEE 62704-4 for FEM.  
288

## 289 **5.3. Computational model**

290

291 This section provides the requirements related to the computational model.  
292

### 293 **5.3.1. EUT model**

294

295 The procedure for modelling the EUT shall be described in the RF exposure technical brief.  
296 Relevant mechanical dimensions and material properties shall be provided, along with the  
297 associated tolerances.  
298

299 It is often necessary to simplify, omit or substitute certain aspects of the EUT model to  
300 reduce simulation times and accommodate memory limitations. A description of these  
301 modifications, and the expected impact on the assessment results, shall be provided in the  
302 RF exposure technical brief.  
303

### 304 **5.3.2. EUT excitation and loading**

305

306 The excitation(s) applied to the EUT model must match the corresponding transmit  
307 waveforms as closely as possible. If these consist of unmodulated or narrowband  
308 modulated carriers, i.e. the requirements for a frequency-domain assessment outlined in  
309 section 5.3.3 of RSS-102.NS.MEAS are met, the spectrum of the simulated emissions shall  
310 include all frequency components for which the field levels exceed the corresponding  
311 sensitivity levels specified in section 5.3.5.1 of RSS-102.NS.MEAS. These shall be  
312 identified through preliminary measurements, using a field probe which meets the  
313 requirements outlined in sections 5.3.5.1, 5.3.5.2, 5.3.5.3 and 5.3.6.2 of RSS-102.NS.  
314 MEAS. Relative agreement between the levels of simulated and measured frequency  
315 components shall be demonstrated in the RF exposure technical brief. This may be done  
316 either by showing:

- 317 • plots illustrating good correlation between the simulated and measured values or  
318

- 319       • the deviation between the simulated and measured values are within the combined  
320       uncertainty using equations 15 and 8 of IEC/IEEE 62704-1 and IEC/IEEE 62704-4,  
321       respectively.  
322

323 If the EUT includes components which are loaded, e.g. a WPT client or an RFID tag, the  
324 impact of loading on the emission spectra shall be modelled as closely as possible to  
325 ensure that the computational model is able to capture the worst-case exposure ratio(s).  
326

327 It should be noted that additional requirements related to WPT implementations are  
328 provided in Annex B.  
329

330 For aperiodic or broadband-modulated EUT emissions, an [inquiry](#) proposing a conservative  
331 excitation and/or load modelling approach shall be submitted to ISED.  
332

### 333 **5.3.3. Simulation parameters and computational resources**

334

335 All relevant simulation parameters, such as those related to the meshing, boundary  
336 conditions, convergence, etc., as well as the computational resources required to  
337 reproduce the simulation results, shall be provided in the RF exposure technical brief.  
338

### 339 **5.3.4. Phantom properties**

340

341 For assessments against the basic restrictions, it is necessary to model a tissue-equivalent  
342 phantom within which the induced SAR and/or internal E-field can be evaluated. At the time  
343 of this writing, a general and internationally accepted approach for modelling the interaction  
344 between human tissue and RF fields below 10 MHz is not yet available.  
345

346 When assessing local exposure in the body, torso or limbs, the flat elliptical phantom  
347 defined in IEC/IEEE 62209-1528, with the material properties summarized in Table 5-1,  
348 may be used. The dimensions of the phantom may be reduced, provided that there is no  
349 measurable effect on the assessment results. This shall be demonstrated in the RF  
350 exposure technical brief.  
351

352 Otherwise, a detailed [inquiry](#) proposing a conservative phantom definition shall be  
353 submitted to ISED for approval.  
354

355 **Table 5-1 – Tissue-equivalent material properties for a flat and homogeneous**  
356 **phantom intended for assessing local exposure in the body / torso.**

Property	Symbol	Value
Dielectric constant	$\epsilon_r$	55 (-)
Electrical conductivity	$\sigma$	0.75 S/m

Mass density	$\rho$	1000 kg/m <sup>3</sup>
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357  
358 **Note:** The material properties in Table 5-1 stem from IEC/IEEE 62209-1528. Although the  
359 requirements in IEC/IEEE 62209-1528 are limited to  $\geq 4$  MHz, the material properties may  
360 be used below 4 MHz for the purposes of RSS-102.NS.SIM.

361  
362 **5.3.5. Uncertainty**

363  
364 This section provides the requirements related to computational uncertainty analysis.

365  
366 **5.3.5.1. General requirements**

367  
368 A complete uncertainty analysis shall be conducted and presented in accordance with the  
369 international standard that most closely aligns with the chosen computational method, e.g.  
370 IEC/IEEE 62704-1 for FDTD/FIT or IEC/IEEE 62704-4 for FEM. The uncertainty budget,  
371 which shall be provided in the RF exposure technical brief, should demonstrate that the  
372 expanded ( $k = 2$ ) uncertainty of the computational model is  $\leq 30\%$ . Otherwise, an [inquiry](#)  
373 shall be submitted to ISED.

374  
375 The steps taken in evaluating each component of the uncertainty budget shall be provided  
376 in the RF exposure technical brief.

377  
378 **5.3.5.2. Simulation uncertainty**

379  
380 Deviations from the prescribed procedures for evaluating the various simulation  
381 uncertainties may be necessary, as international standards such as IEC/IEEE 62704-1/-4  
382 were not developed for the frequency range covered here. For example:

- 383
- 384 i. Mesh resolution (FDTD / FIT) – if the requirements provided in section 7.2.3 of  
385 IEC/IEEE 62704-1 are too computationally burdensome, this uncertainty may  
386 instead be evaluated by increasing the total number of mesh cells by a factor 2 or,  
387 when applying sub-gridding, by a factor of 4 in the region of highest exposure  
388 (including the source antenna(s)).
  - 389
  - 390 ii. Boundary conditions (FDTD / FIT / FEM) – if the requirements provided in section  
391 7.2.4 of IEC/IEEE 62704-1 or section 7.2.3 of IEC/IEEE 62704-4 are too  
392 computationally burdensome, this uncertainty may instead be evaluated by  
393 increasing the size of the bounding box by 50% in all directions.
  - 394
  - 395 iii. Convergence (FDTD / FIT) – if the requirements provided in section 7.2.6 of  
396 IEC/IEEE 62704-1 are too computationally burdensome, the following may be  
397 applied: the simulation time required for convergence,  $T_{\text{conv}}$ , shall be long enough to

398 ensure that the maximum RMS field level remains in the same voxel when the  
399 simulation time is increased to  $1.5 T_{conv}$ , i.e. that the location of the maximum RMS  
400 field level does not change. In addition, the field level associated with this voxel shall  
401 not change by more than 2%. Either the E- or H-field may be considered, whichever  
402 is dominant in the context of exposure. The percent change in the maximum RMS  
403 field level when increasing from  $T_{conv}$  to  $1.5 T_{conv}$  shall be taken as the convergence  
404 uncertainty, with a rectangular distribution.

405  
406 iv. Phantom dielectrics (FDTD / FIT / FEM) – when using the flat and homogeneous  
407 phantom with the material properties summarized in Table 5-1, this uncertainty may  
408 be set to zero.

409  
410 For all other deviations, an [inquiry](#) shall be submitted to ISED.

### 411 **5.3.5.3. EUT model uncertainty and validation**

412  
413  
414 A complete uncertainty analysis involves performing measurements to validate the EUT  
415 model and determine its uncertainty. For emissions above 4 MHz, this shall be performed  
416 in accordance with section 7.3 in IEC/IEEE 62704-1 (FDTD/FIT) or IEC/IEEE 62704-4  
417 (FEM), with IEC/IEEE 62209-1528 serving as a reference for SAR measurements. This  
418 extends to emissions below 4 MHz, with the exception of section 7.3.3 in IEC/IEEE 62704-  
419 1/-4, which prescribes SAR measurements for validation. While these requirements form  
420 the basis for the approach, modifications may be necessary for practical reasons. The  
421 following requirements may be applied in lieu of section 7.3.3 in IEC/IEEE 62704-1/-4:

422  
423 i. Instead of SAR measurements, incident field measurements may be performed  
424 throughout the exposure region. This may be limited to either the E- or H-field, if it is  
425 demonstrated that the other field does not contribute to the resulting exposure ratio.

426  
427 ii. Where possible, the worst-case exposure scenario and separation distance(s) shall  
428 be considered.

429  
430 iii. Field probes used to perform the measurements shall meet the requirements  
431 outlined in sections [5.3.4](#), [5.3.5.1](#), [5.3.5.2](#) and [5.3.5.3](#) of [RSS-102.NS.MEAS](#). They  
432 should also meet the requirements outlined in sections [5.3.6](#) of [RSS-102.NS.MEAS](#),  
433 otherwise, the effects of spatial averaging and anisotropy shall be incorporated into  
434 the validation, either by post-processing the simulated field results or including the  
435 probe antenna(s) in the computational model for validation.

436  
437 iv. When defining the points in space at which measurements will be compared with  
438 simulation results, the following considerations apply:

- 439 a. Measurements shall be performed at no fewer than 25 points. If possible,  
440 these shall be distributed over at least two surfaces, with one being at the  
441 separation distance, i.e. on the evaluation surface or nearest surface of the  
442 exposure region.
- 443 b. If possible, one of the measurement points shall capture the maximum field  
444 level within the exposure region.
- 445 c. The distance between neighboring measurement points shall not exceed 100  
446 mm, and should be small enough that the difference in neighbouring field  
447 levels is less than 6 dB.
- 448 d. If possible, the spatial distribution of the measurement points shall be such  
449 that a good spread of field levels within 20 dB of the maximum field level is  
450 obtained.

451  
452 v. With regard to the uncertainty budget:

- 453 a. The uncertainty of the EUT model may be calculated in accordance with  
454 section 7.3.3 in IEC/IEEE 62704-1/-4, but with squared field values, e.g.  $|E|^2$   
455 or  $|H|^2$ , being used in place of SAR values.

456  
457 The uncertainty of the EUT model based on E-field measurements only may  
458 be evaluated according to

$$459 \quad U_{E,d}[\%] = 100 \times \max \frac{|E_{ref}(n) - E_{num}(n)|}{E_{refmax}} \quad (1)$$

460  
461 where

462  $E_{ref}(n)$  is the experimentally determined local E-field value at position  
463 n or its accurate reference solution;

464  $E_{num}(n)$  is the numerically determined E-field value at position n; and

465  $E_{refmax}$  is the experimentally determined maximum E-field value of all  
466 measured positions or its accurate reference solution.

467  
468 The E-field values may be replaced with H-field values for the calculation of  
469 the H-field uncertainty  $U_{H,d}$ .

- 470 b. The uncertainty of the flat phantom model is zero. If other phantoms are  
471 used, a detailed inquiry proposing conservative phantom uncertainty shall be  
472 submitted to ISED for approval.
  - 473 c. The uncertainty of the measurement equipment and procedure shall be  
474 estimated as closely as possible based on information provided by the test  
475 equipment manufacturer, field probe positioning, etc.
- 476

477 vi. The procedure found in section 7.3.4 of IEC/IEEE 62704-1 (FDTD/FIT) or section  
478 7.3.5 of IEC/IEEE 62704-4 (FEM) shall be followed to demonstrate that the EUT  
479 model is valid.  
480

481 If measurements within the exposure region are prohibited by physical constraints, minor  
482 modifications may be applied to the EUT to allow access, provided that they do not have a  
483 significant impact on the assessment results. For example, non-conductive enclosure  
484 materials may be displaced or removed if it is demonstrated, via simulation or otherwise,  
485 that they do not significantly impact the field distribution within the exposure region.  
486 Alternatively, individual portions of the EUT may be modelled and validated independently,  
487 if it is demonstrated that the overall fields produced by the EUT are equivalent to the  
488 superposition of the fields produced by each portion in isolation. If neither option is viable,  
489 an [inquiry](#) shall be submitted to ISED.  
490

491 A detailed description of the EUT model validation procedure shall be provided in the RF  
492 exposure technical brief, along with model validation results and plots or tables  
493 demonstrating agreement between measured and simulated results.  
494

#### 495 **5.4. Exposure assessments**

496

497 Once the computational model has been validated, exposure assessments can be  
498 performed. This section provides the requirements in this regard.  
499

##### 500 **5.4.1. Number of assessments**

501

502 Assessments shall be performed for each exposure scenario and separation distance  
503 identified in sections [4.1 and 4.2 of RSS-102.NS.MEAS](#), respectively, unless sufficient  
504 rationale is provided for a reduced set of worst-case exposure scenarios and separation  
505 distances in the RF exposure technical brief.  
506

##### 507 **5.4.2. Assessments against the basic restrictions**

508

509 This sub-section provides the requirements for computational assessments against the  
510 basic restrictions.  
511

###### 512 **5.4.2.1. Phantom**

513

514 When performing an exposure assessment against the basic restrictions, a tissue-  
515 equivalent phantom shall be added to the computational model at the corresponding  
516 separation distance, and oriented to yield worst-case exposure.  
517

518 For the flat phantom defined in section 5.3.4, one of the larger surfaces shall face the EUT  
519 such that it captures the highest incident fields. Care should be taken to ensure that the

520 edges and corners of the phantom are not placed in high-field regions, as the induced  
521 quantities may become artificially high in these areas.

522

#### 523 **5.4.2.2. Internal E-field**

524

525 The spatial-peak RMS E-field strength within the phantom shall be identified using the  
526 meshing approach of IEC/IEEE 62704-1 for FDTD/FIT or IEC/IEEE 62704-4 for FEM, **but**  
527 **without performing any spatial averaging**. The transmit duty cycle(s) employed by the  
528 EUT shall not be incorporated into the assessment as the NS limits are based on  
529 instantaneous exposure.

530

531 Assuming the associated EUT emissions meet the conditions for a frequency-domain  
532 assessment, the NS-based exposure ratio,  $ER_{NS-BR}$ , can be calculated as follows:

533

$$ER_{NS-BR} = \sum_{m=1}^M \frac{E_{int}(f_m)}{E_{BR}(f_m)} \quad (2)$$

534

535 where:

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- $M$  is the number of frequency components associated with the internal E-field assessment;
- $E_{int}(f_m)$  is the internal E-field contribution of the  $m$ -th frequency component, and
- $E_{BR}(f_m)$  is the applicable basic restriction for the internal E-field of the  $m$ -th frequency component.

Particular care should be taken when evaluating the spatial-peak (maximum internal E-field) as this value may be subject to discretization uncertainties. It is necessary to determine if the spatial-peak obtained is sufficiently converged. This may be evaluated by additional simulations with refined mesh resolution at the location of the spatial-peak. In situations where the spatial-peak is sufficiently converged, an increase of the mesh resolution by a factor of two, should lead to a negligible difference between the original and the new simulation. Where the spatial-peak is not sufficiently converged, there will be a large deviation between the spatial-peaks recorded for both simulations.

One or more plots demonstrating the E-field distribution within the phantom shall be provided, and the maximum internal E-field result should be clearly identified. The maximum  $ER_{NS-BR}$  result shall be reported.

It is important to note when evaluating internal E-field, the duty cycle(s) employed by the WPT source(s) shall not be incorporated as the corresponding basic restrictions are for instantaneous exposure.

559 **5.4.3. Assessments against reference levels**  
560

561 When neither an assessment against the basic restrictions, nor a measurement-based  
562 assessment against the reference levels are feasible, a computational assessment against  
563 the reference levels shall be performed. This section provides the requirements in this  
564 regard, provided that the emissions consist of unmodulated or narrowband modulated  
565 carriers, i.e. they meet the requirements for a frequency-domain assessment outlined in  
566 section 5.3.3 of RSS-102.NS.MEAS. Otherwise, an [inquiry](#) shall be submitted to ISED in  
567 accordance with section 5.3.2.  
568

569 Based on the relevant requirements provided in section 5 of RSS-102.NS.MEAS, excluding  
570 section 5.4.3 of RSS-102.NS.MEAS, the values of  $ER_{NS-ERL}$  and  $ER_{NS-HRL}$  shall be  
571 computed on the evaluation surface, i.e. at the corresponding separation distance, for each  
572 user-accessible side of the EUT.  
573

574 In addition, plots of the RMS E- and H- fields on each evaluation surface shall be provided.  
575 The maximum RMS field level should be clearly indicated on each plot. When the excitation  
576 and loading produce multiple frequency components to be included in the assessment, the  
577 following procedures shall be followed:  
578

- 579 i. if a fixed fundamental, carrier or pulse repetition frequency is employed, provide  
580 plots for this frequency and a table summarizing the maximum RMS field levels on  
581 the evaluation surface for each frequency component included in the assessment;  
582
- 583 ii. if a variable fundamental, carrier or pulse repetition frequency is employed, follow  
584 the requirements in (i) for the frequency yielding the worst-case exposure, or  
585
- 586 iii. if multiple fundamental, carrier or pulse repetition frequencies are employed  
587 simultaneously, follow the requirements in (i) for each of these frequencies.  
588

589 **5.5. Total exposure**  
590

591 Compliance with the limits to prevent NS effects is demonstrated if the worst-case total  
592 exposure ratio (TER) corresponding to the effect are less than or equal to 1. NS- and SAR-  
593 based TERs are evaluated separately, based on the corresponding NS- or SAR-based  
594 exposure ratios. Refer to section 8 of RSS-102 for details.  
595

596 **6. RF exposure technical brief**  
597

598 The RF exposure technical brief shall include all information required to reproduce the  
599 simulation results, including information related to the test configurations, methods and  
600 equipment. Annex A provides a comprehensive list of the required information.  
601

602 If the EUT produces emissions above 10 MHz, additional assessments are required to fully  
603 demonstrate compliance. In this case, the RF exposure technical brief shall accommodate  
604 any additional reporting requirements identified in the RSS-102 series of standards.  
605

DRAFT

606 **Annex A. Summary of required information for the RF exposure technical brief**  
 607 **(normative)**  
 608

609 This annex provides a comprehensive summary of the information that must be included in  
 610 the RF exposure technical brief to demonstrate compliance with RSS-102.NS.SIM.

611  
 612 **A.1. General information**  
 613

614 Table A-1 summarizes the general information to be included in the RF exposure technical  
 615 brief.

616  
 617 **Table A-1 – General information to be included in the RF exposure technical brief**

Item description	Related section(s)
Test laboratory information, including ISED recognition and accreditation, as well as the evaluation dates	
EUT use-cases and key RF exposure conditions	4
List of the NS-based separation distances associated with each individual assessment with sufficient rationale as required	4
Description of the nature, intended purpose and theory of operation of the EUT, including information related to certification (i.e. ISED certification number, HVIN, PMN, HMN etc.)	4
Description of each antenna within the EUT, including the number of elements, element type, input impedance/inductance/capacitance, shielding/field shaping, relevant dimensions and material properties, etc.	4
Description of the waveforms generated by each transmitter within the EUT, including the fundamental wave shape (sinusoidal, triangular, rectangular or otherwise) and frequency, applied modulation and 99% OBW, duty factor, etc.	4
Description of EUT behaviour in each operating state, and the triggering conditions and timings for state transitions	4
Description of the conducted power of excitation level applied to each antenna based on the applicable use-cases and operating states	4
List of the methods used for each assessment against the NS-based limits with sufficient rationale as required	4
Summary of the exposure ratio results obtained for each assessment along with the worst-case NS-based TERs	5.5

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**A.2. Computational assessments**

Table A-2 summarizes the information to be included in the RF exposure technical brief for computational assessments, whether they be against the basic restrictions or the reference levels.

**Table A-2 – Information to be included in the RF exposure technical brief regarding computational assessments against the basic restrictions and/or reference levels**

Item description	Related section(s)
Computational tool and method, i.e. FDTD/FIT and FEM	5.1
Code verification results (may be included in a separate attachment)	5.2
Description and illustrations of the EUT model, including mechanical dimensions, material properties, tolerances and any simplifications made to achieve practical memory requirements and simulation times	5.3.1
Description and illustrations of the excitation and loading applied to the model, and a comparison between measured and simulated excitations.	5.3.2
Summary of the simulation parameters and computational resource requirements, including: <ul style="list-style-type: none"> <li>i. Computational resources used to perform the assessment</li> <li>ii. Minimum computational requirements to reproduce the results</li> <li>iii. Conditions for simulation completion, and total simulation time</li> <li>iv. Boundary conditions and the size of the computational domain</li> <li>v. Mesh type, mesh settings (density/step sizes, optimization criteria, etc.) and total number of mesh cells</li> <li>vi. Any other relevant parameters required to reproduce the results</li> </ul>	5.3.3
Shape, dimensions and material properties of the tissue-equivalent phantom for assessments against the basic restrictions	5.3.4
Detailed uncertainty analysis, including: <ul style="list-style-type: none"> <li>i. Complete uncertainty budget in accordance with the applicable international standard, e.g. IEC/IEEE 62704-1 or 62704-4</li> <li>ii. Description of how each uncertainty value was obtained, including any deviations from the above standards</li> <li>iii. Detailed description and illustration of the EUT model validation procedure and results</li> </ul>	5.3.5.1 and 5.3.5.2

<p>iv. Statement of the expanded uncertainty, which should be <math>\leq 30\%</math></p>	
<p>Detailed description of the exposure assessment procedure and results, including all exposure conditions and separation distances, with rationale for reduction to the worst-case configurations</p>	<p>5.4.1</p>
<p>For assessments against the basic restrictions, include:</p> <ul style="list-style-type: none"> <li>i. Illustration(s) showing the relative positions and orientations of the EUT and tissue-equivalent phantom</li> <li>ii. Detailed description of the evaluation procedure for internal E-field within the phantom</li> <li>iii. Plot(s) of the internal E-field within the phantom</li> <li>iv. Locations and values of the maximum NS-based exposure ratios, i.e. <math>ER_{NS-BR}</math>.</li> </ul>	<p>5.4.2.1 and 5.4.2.2</p>
<p>For assessments against the reference levels, include:</p> <ul style="list-style-type: none"> <li>i. Illustration(s) showing the relative positions and orientations of the EUT and evaluation surface(s)</li> <li>ii. Plots of the E- and H-field levels on the evaluation surface(s)</li> <li>iii. Locations and values of the maximum NS-based exposure ratio(s), i.e. <math>ER_{NS-ERL}</math> and/or <math>ER_{NS-HRL}</math></li> </ul>	<p>5.4.3</p>

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628

629 **Annex B. Additional requirements for wireless power transfer (WPT)**  
630 **implementations (normative)**

631  
632 This annex provides additional requirements specific to WPT implementations.

633  
634 All the requirements stated in Annex D of RSS-102.NS.MEAS are applicable in the context  
635 of RSS-102.NS.SIM; they are not repeated here for brevity. However, additional  
636 requirements specific to simulation-based assessments are listed below.

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638 **B.1. Computational assessments for small WPT implementations**

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640 A simplified and conservative computational assessment method may be applied for  
641 devices with WPT source capabilities that meet the following conditions:

- 642
- 643 •  $D_s \leq 20$  cm, where  $D_s$  is the maximum linear dimension of the WPT source  
644 antenna. If the antenna consists of an array of elements, e.g. coils, electrodes, etc.,  
645 the entire array needs to meet this condition.
  - 646
  - 647 • the device enclosure on the side associated with WPT, e.g. the charging surface, is  
648 flat, thus accommodating a flat phantom.

649  
650 If this is the case, the following procedure may be applied when performing a computational  
651 assessment:

- 652
- 653 i. The EUT may be limited to the WPT source device, i.e. a representative WPT client  
654 would not be considered part of the EUT.
  - 655
  - 656 ii. The WPT source antenna shall be continuously driven by the maximum current level  
657 that the transmitter is capable of supplying.
  - 658
  - 659 iii. A flat homogeneous phantom shall be employed at touch position (0 cm), i.e. the  
660 outer surface of the phantom is in contact with the enclosure of the WPT source,  
661 with the WPT source's charging surface facing the phantom. In addition:
    - 662 a. The material properties of Table 5-1 should be used.
    - 663 b. The dimensions of the phantom shall be large enough that increasing them in  
664 any direction has no measurable impact of the assessment results. They  
665 should be more than twice the value of  $D_s$  in each direction; however, the  
666 depth of the phantom may be smaller if this is demonstrated not to have a  
667 measurable impact on the results.
    - 668 c. The phantom shall be positioned to ensure maximum exposure, e.g. centred  
669 on the WPT source antenna.
- 670

- 671 iv. Uncertainty analysis and model validation shall be performed as per section 5.3.5.  
672  
673 v. The values of  $ER_{SAR-BR}$  and  $ER_{NS-BR}$  shall be evaluated in accordance with section  
674 5.5, and the corresponding TERs shall be calculated.  
675

676 Compliance may be demonstrated in this way, provided the following conditions are met:  
677

- 678 •  $ER_{SAR-BR} < 0,75$  (nominal)  
679 •  $ER_{NS-BR} < 0,75$  (nominal)  
680 •  $TER_{therm} \leq 1$   
681 •  $TER_{NS} \leq 1$   
682

683 Rationale for the use of this method shall be documented in the RF exposure technical  
684 brief, along with the assessment results. When the conditions above cannot be met, a full  
685 computational analysis as per section 5 shall be provided.